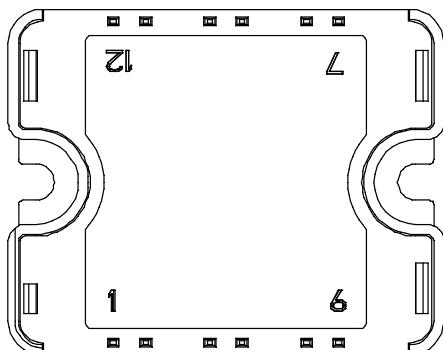
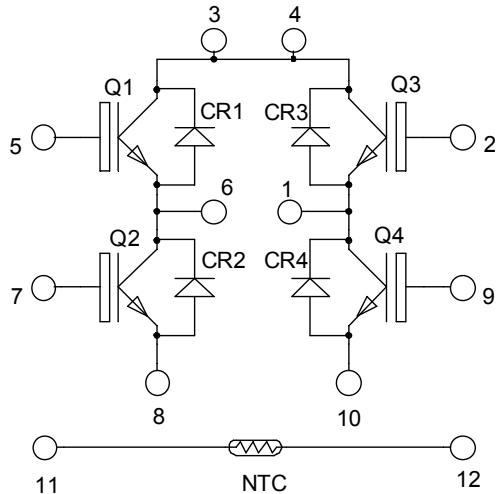


**Full - Bridge  
Fast Trench + Field Stop IGBT®  
Power Module**
**V<sub>CES</sub> = 1200V  
I<sub>C</sub> = 25A @ T<sub>c</sub> = 80°C**


Pins 3/4 must be shorted together

**Application**

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

**Features**

- Fast Trench + Field Stop IGBT® Technology
  - Low voltage drop
  - Low tail current
  - Switching frequency up to 20 kHz
  - Soft recovery parallel diodes
  - Low diode VF
  - Low leakage current
  - RBSOA and SCSOA rated
- Very low stray inductance
  - Symmetrical design
- Internal thermistor for temperature monitoring
- High level of integration

**Benefits**

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- Each leg can be easily paralleled to achieve a phase leg of twice the current capability
- RoHS Compliant

**Absolute maximum ratings**

Symbol	Parameter	Max ratings	Unit
V <sub>CES</sub>	Collector - Emitter Breakdown Voltage	1200	V
I <sub>C</sub>	Continuous Collector Current	T <sub>C</sub> = 25°C T <sub>C</sub> = 80°C	40 25
I <sub>CM</sub>	Pulsed Collector Current		
V <sub>GE</sub>	Gate – Emitter Voltage	T <sub>C</sub> = 25°C	50
P <sub>D</sub>	Maximum Power Dissipation	T <sub>C</sub> = 25°C	156
RBSOA	Reverse Bias Safe Operation Area	T <sub>j</sub> = 125°C	50A @ 1150V

 **CAUTION:** These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on [www.microsemi.com](http://www.microsemi.com)

All ratings @  $T_j = 25^\circ\text{C}$  unless otherwise specified

### Electrical Characteristics

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
$I_{CES}$	Zero Gate Voltage Collector Current	$V_{GE} = 0\text{V}$ , $V_{CE} = 1200\text{V}$	$T_j = 25^\circ\text{C}$			250	$\mu\text{A}$
$V_{CE(\text{sat})}$	Collector Emitter Saturation Voltage			1.7	2.1		V
$V_{GE(\text{th})}$	Gate Threshold Voltage	$V_{GE} = V_{CE}$ , $I_C = 1\text{mA}$	$T_j = 125^\circ\text{C}$	2.0		6.5	V
$I_{GES}$	Gate – Emitter Leakage Current	$V_{GE} = 20\text{V}$ , $V_{CE} = 0\text{V}$				400	nA

### Dynamic Characteristics

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
$C_{ies}$	Input Capacitance	$V_{GE} = 0\text{V}$ , $V_{CE} = 25\text{V}$ $f = 1\text{MHz}$		1800			pF
$C_{res}$	Reverse Transfer Capacitance			82			
$T_{d(on)}$	Turn-on Delay Time	$V_{GE} = \pm 15\text{V}$ $V_{Bus} = 600\text{V}$ $I_C = 25\text{A}$ $R_G = 27\Omega$	Inductive Switching ( $25^\circ\text{C}$ )	90			ns
$T_r$	Rise Time			30			
$T_{d(off)}$	Turn-off Delay Time			420			
$T_f$	Fall Time			70			
$T_{d(on)}$	Turn-on Delay Time	$V_{GE} = \pm 15\text{V}$ $V_{Bus} = 600\text{V}$ $I_C = 25\text{A}$ $R_G = 27\Omega$	Inductive Switching ( $125^\circ\text{C}$ )	90			ns
$T_r$	Rise Time			50			
$T_{d(off)}$	Turn-off Delay Time			520			
$T_f$	Fall Time			90			
$E_{on}$	Turn-on Switching Energy	$V_{GE} = \pm 15\text{V}$ $V_{Bus} = 600\text{V}$ $I_C = 25\text{A}$ $R_G = 27\Omega$	$T_j = 25^\circ\text{C}$ $T_j = 125^\circ\text{C}$ $T_j = 25^\circ\text{C}$ $T_j = 125^\circ\text{C}$	1.9			mJ
$E_{off}$	Turn-off Switching Energy			2.5			
				1.9			
				2.9			

### Reverse diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
$V_{RRM}$	Maximum Peak Repetitive Reverse Voltage	$V_R = 1200\text{V}$	$T_j = 25^\circ\text{C}$	1200			V
$I_{RM}$	Maximum Reverse Leakage Current				100		$\mu\text{A}$
$I_F$	DC Forward Current		$T_c = 80^\circ\text{C}$	25			A
$V_F$	Diode Forward Voltage	$I_F = 25\text{A}$	$T_j = 25^\circ\text{C}$ $T_j = 125^\circ\text{C}$	1.6	2.1		V
$t_{rr}$	Reverse Recovery Time			160			
$Q_{rr}$	Reverse Recovery Charge	$I_F = 25\text{A}$ $V_R = 600\text{V}$ $di/dt = 1500\text{A}/\mu\text{s}$	$T_j = 25^\circ\text{C}$ $T_j = 125^\circ\text{C}$	270			$\mu\text{C}$
$E_r$	Reverse Recovery Energy			2.7			
			$T_j = 25^\circ\text{C}$	4.8			
			$T_j = 125^\circ\text{C}$	1			
			$T_j = 125^\circ\text{C}$	1.9			

**Thermal and package characteristics**
**Symbol**    **Characteristic**

			Min	Typ	Max	Unit
$R_{thJC}$	Junction to Case Thermal Resistance	IGBT			0.80	°C/W
		Diode			1.5	
$V_{ISOL}$	RMS Isolation Voltage, any terminal to case t=1 min, I isol<1mA, 50/60Hz	2500				V
$T_J$	Operating junction temperature range	-40		150		°C
$T_{STG}$	Storage Temperature Range	-40		125		
$T_C$	Operating Case Temperature	-40		100		
Torque	Mounting torque	To heatsink	M4	2.5	4.7	N.m
Wt	Package Weight				80	g

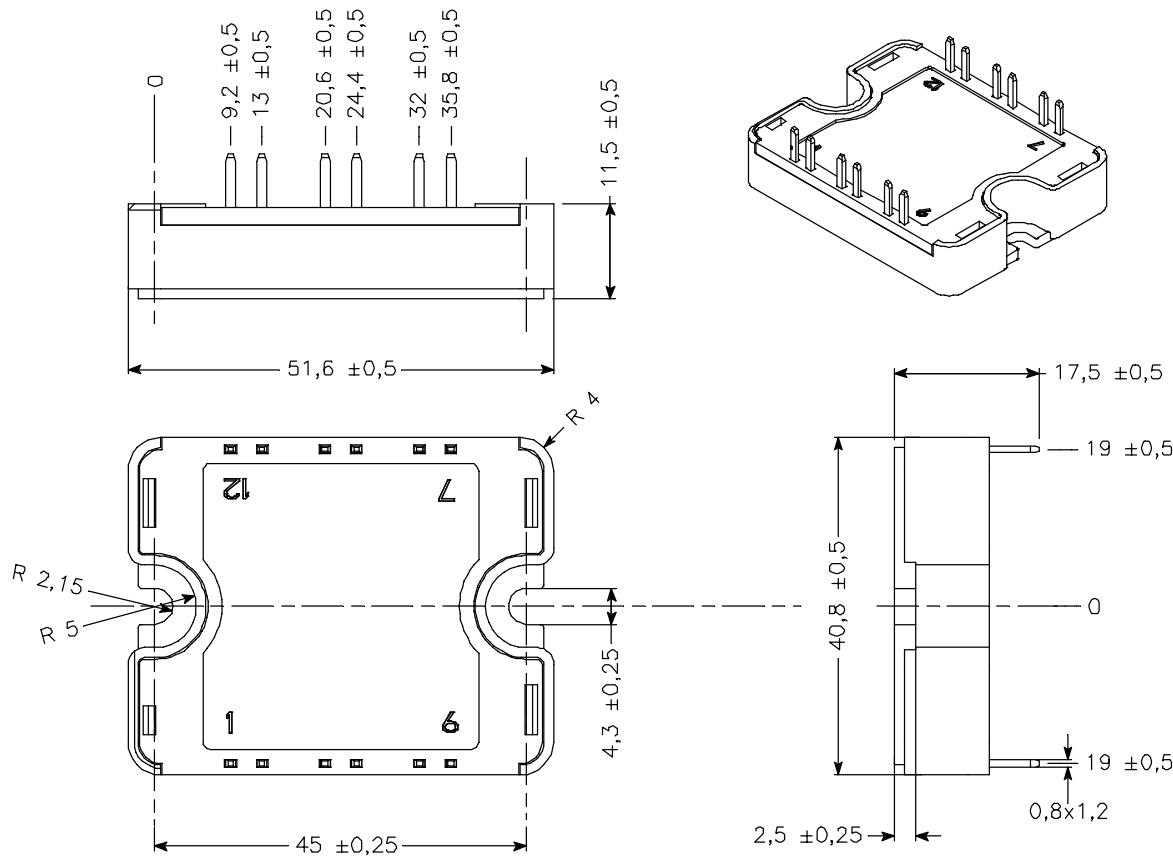
**Temperature sensor NTC** (see application note APT0406 on www.microsemi.com for more information).

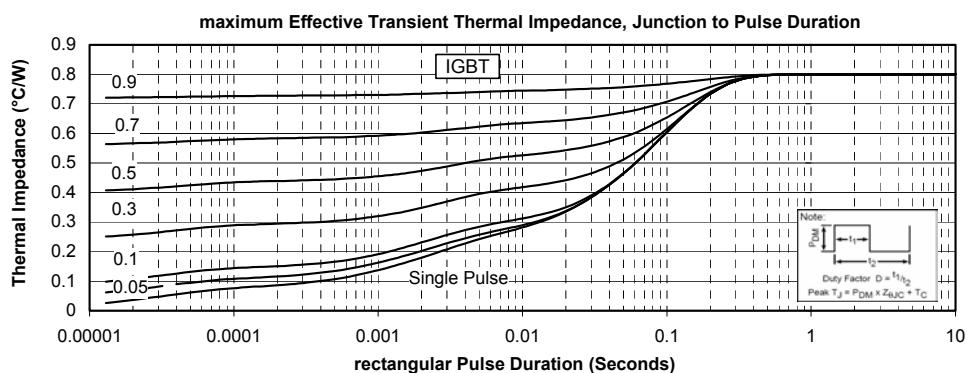
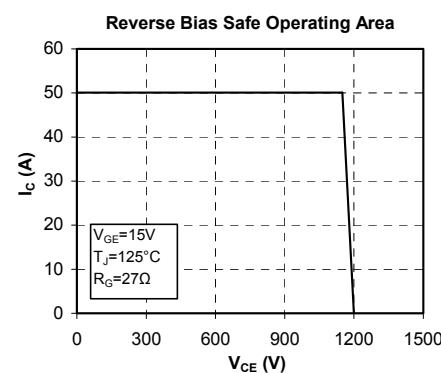
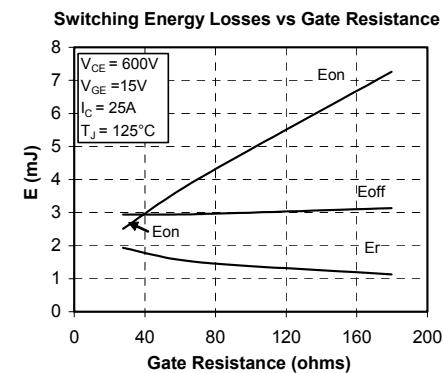
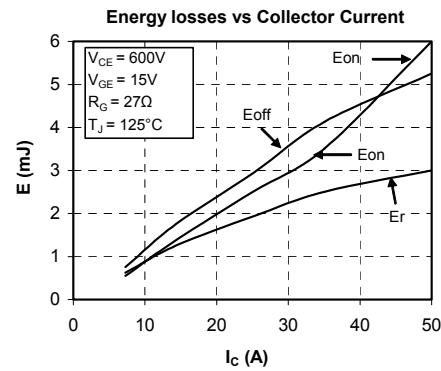
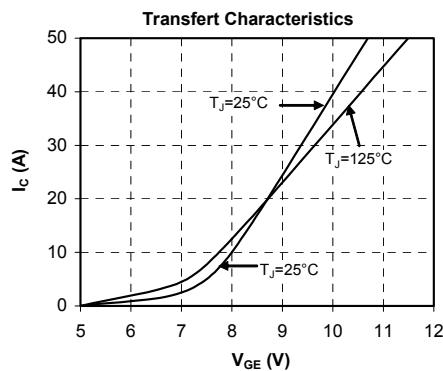
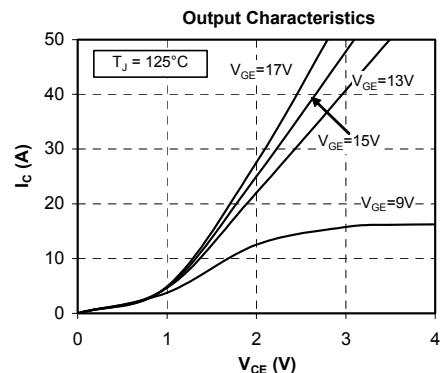
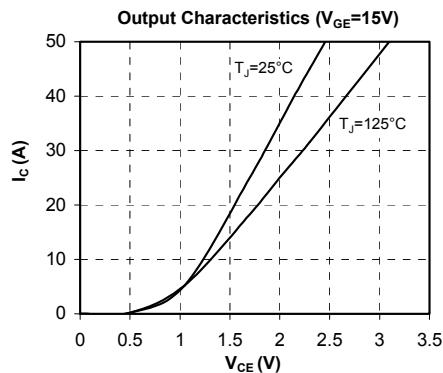
**Symbol**    **Characteristic**

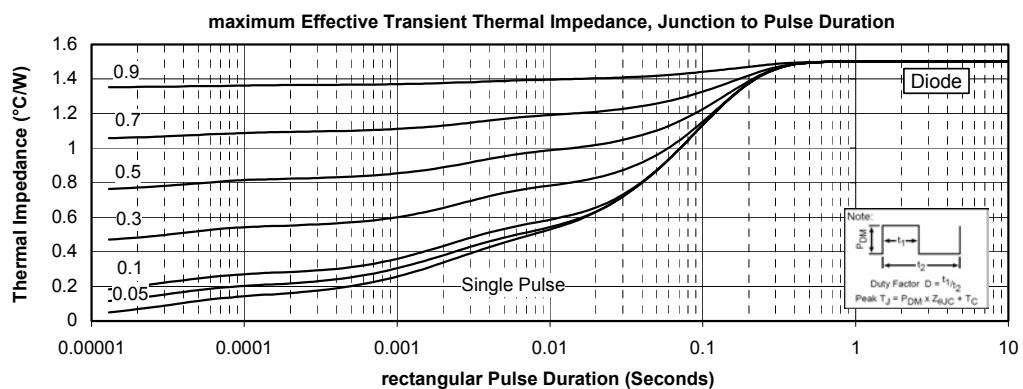
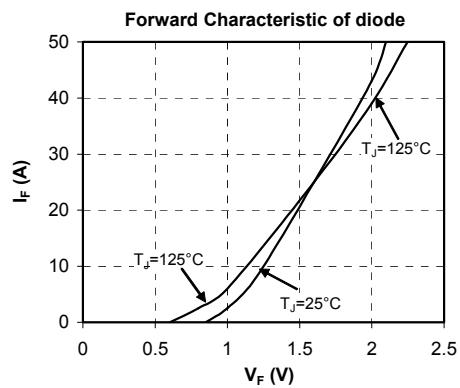
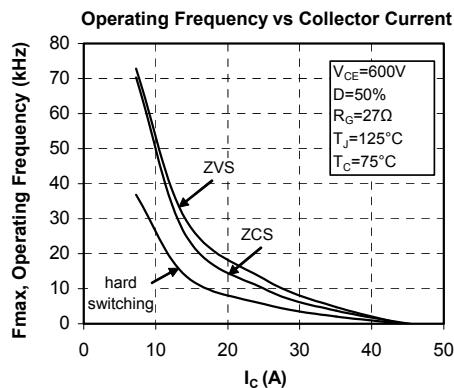
		Min	Typ	Max	Unit
$R_{25}$	Resistance @ 25°C		50		kΩ
$B_{25/85}$	$T_{25} = 298.15 \text{ K}$		3952		K

$$R_T = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$

T: Thermistor temperature  
R<sub>T</sub>: Thermistor value at T

**SP1 Package outline** (dimensions in mm)

 See application note 1904 - Mounting Instructions for SP1 Power Modules on [www.microsemi.com](http://www.microsemi.com)

**Typical Performance Curve**




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